

N-Channel 600V MOSFET

Description

The MSF12N60 is a N-channel enhancement-mode MOSFET, providing the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost effectiveness. The ITO-220AB package is universally preferred for all commercial-industrial applications

Features

- · Low On Resistance
- · Simple Drive Requirement
- Low Gate Charge
- Fast Switching Characteristic
- · RoHS compliant package

Application

- Power Factor Correction
- · LCD TV Power
- Full and Half Bridge Power

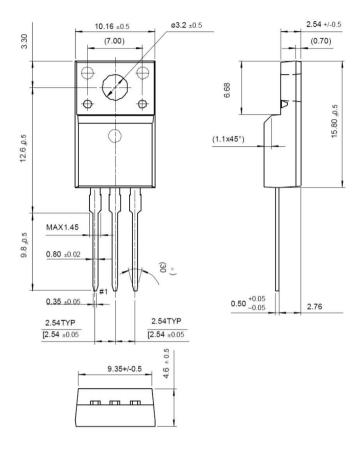
Package type: ITO220-AB

Packing & Order Information

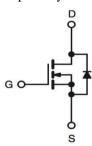
50/Tube; 1,000/Box







Graphic symbol



MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings (Tc=25°C unless otherwise noted)						
Symbol	Parameter	Value	Unit			
V_{DS}	Drain-Source Voltage	600	V			
V _{GS}	Gate-Source Voltage	±30	V			
I_D	Drain Current -Continuous (TC=25°C)	12	A			
	Drain Current -Continuous (TC=100°C)	7.5	A			
I_{DM}	Drain Current Pulsed	48	A			
E _{AS}	Single Pulsed Avalanche Energy	870	mJ			
Iar	Avalanche Current	12	A			
Ear	Repetitive Avalanche Energy	22.5	mJ			
dV/dt	Peak Diode Recovery dV/dt	3.5	V/ns			



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Absolute Maximum Ratings (Tc=25°C unless otherwise noted)						
Symbol	Parameter Value Unit					
P_D	Power Dissipation (TC = 25 °C)	54	W			
	Power Dissipation (TC=100°C)	0.43	W/°C			
T _J ,T _{STG}	Operating and Storage Temperature Range	-55 to +150	°C			

NOTE:

- 1. $TJ=+25^{\circ}C$ to $+150^{\circ}C$.
- 2. Repetitive rating; pulse width limited by maximum junction temperature. 3. ISD=12A, dl/dt<100A/ μ s, VDD<BVDSS, TJ=+150°C.
- 4. IAS=12A, VDD=50V, L=11mH, RG=25 Ω , starting TJ=+25 $^{\circ}$ C.

Off Characteristics						
Symbol	Parameter	Test Conditions	Min	Typ.	Max.	Units
V_{GS}	Gate Threshold Voltage	$V_{DS}=V_{GS},I_{D}$ =250 μ A	2.0		4.0	V
$R_{DS(ON)}$	Static Drain-Source On-Resistance	$V_{GS}=10V,I_{D}=6A$		0.58	0.65	Ω
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS} =0 V , I_{D} =250 μ A	600			V
ΔBV_{DSS} $/\Delta T_J$	Breakdown Voltage Temperature Coefficient	I _D =250μA, Referenced to 25°C		0.5		V/°C
Idss	Zero Gate Voltage Drain Current	V_{DS} =600V , V_{GS} = 0 V V_{DS} =480V , T_{C} = 125°C			1 10	μΑ
I_{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS}=30V$, $V_{DS}=0$ V			100	nA
I_{GSSR}	Gate-Body Leakage Current, Reverse	V_{GS} =-30V, V_{DS} =0V			-100	nA

Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units
C_{ISS}	Input Capacitance	V _{DS} =25V, V _{GS} =0V, f=1.0MHz		1760	2290	pF
Coss	Output Capacitance			182	235	pF
Crss	Reverse Transfer Capacitance			21	28	pF

Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Min	Typ.	Max.	Units
t _{d(on)}	Turn-On Time	V_{DS} =250 V, I_{D} =12A, R_{G} =10 Ω		30	70	ns
$t_{\rm r}$	Turn-On Time			85	180	ns
$t_{\rm d(off)}$	Turn-Off Delay Time			140	280	ns
tf	Turn-Off Fall Time			90	190	ns
Qg	Total Gate Charge	V _{DS} =480V,I _D =12A, V _{GS} =10 V		48	63	nC
Q_{gs}	Gate-Source Charge			8.5		nC
Q_{gd}	Gate-Drain Charge			21		nC

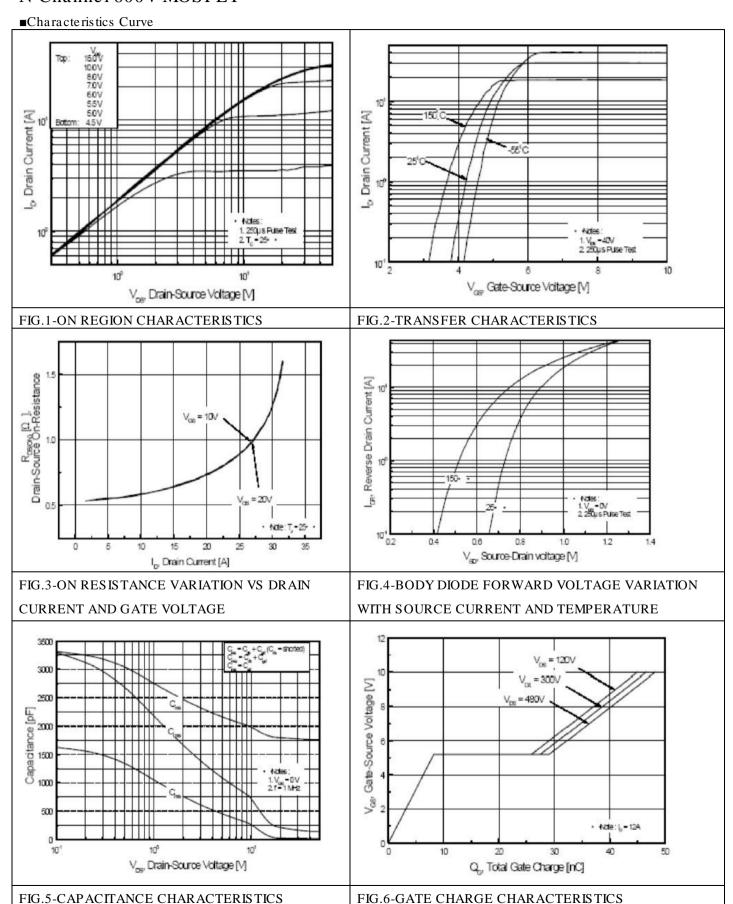


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Source-Drain Diode Maximum Ratings and Characteristics						
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units
I_S	Continuous Source-Drain Diode Forward Current				12	
I _{SM}	ISM Pulsed Source-Drain Diode Forward Current				48	A
V _{SD}	Source-Drain Diode Forward Voltage	$I_{S}=12A$, $V_{GS}=0V$			1.5	V
t _{rr}	Reverse Recovery Time	$I_S=12A$, $V_{GS}=0V$		460		ns
Qrr	Reverse Recovery Charge	diF/dt=100A/µs		4.9		μC



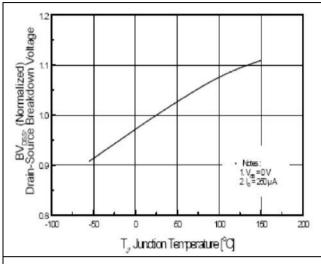
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■Characteristics Curve



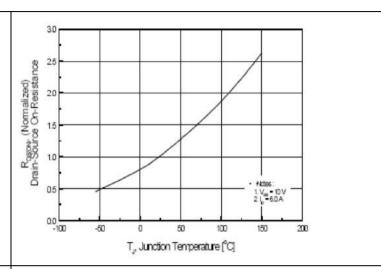


FIG.7-BREAKDOWN VOLTAGE VARIATION VS TEMPERATURE

Operation in Tris Area is Limited by R 2004 100 µs 100 µs 100 µs 100 ms 100 ms

FIG.8-ON-RESISTANCE VARIATION VS TEMPERATURE

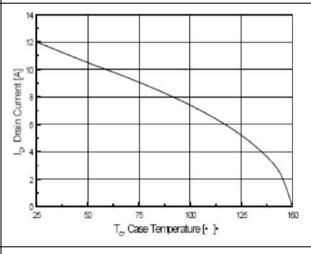


FIG.9-MAXIMUM SAFE OPERATING AREA

FIG.10-MAXIMUM DRAIN CURRENT VS CASE TEMPERATURE

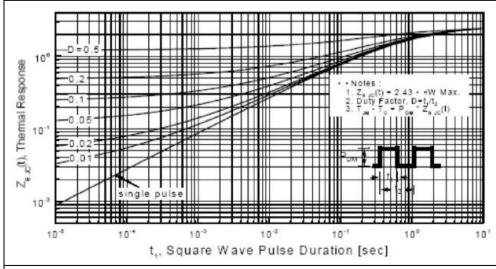


FIG.11-TRANSIENT THERMAL RESPONSE CURVE



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■Characteristics Test Circuit & Waveform

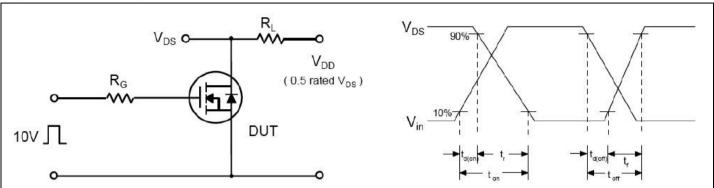


Fig 12. Resistive Switching Test Circuit & Waveforms

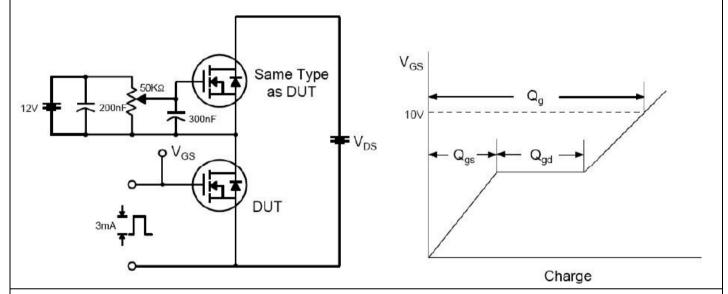


Fig 13. Gate Charge Test Circuit & Waveform

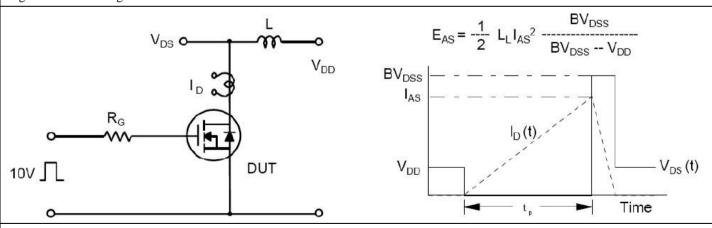


Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms



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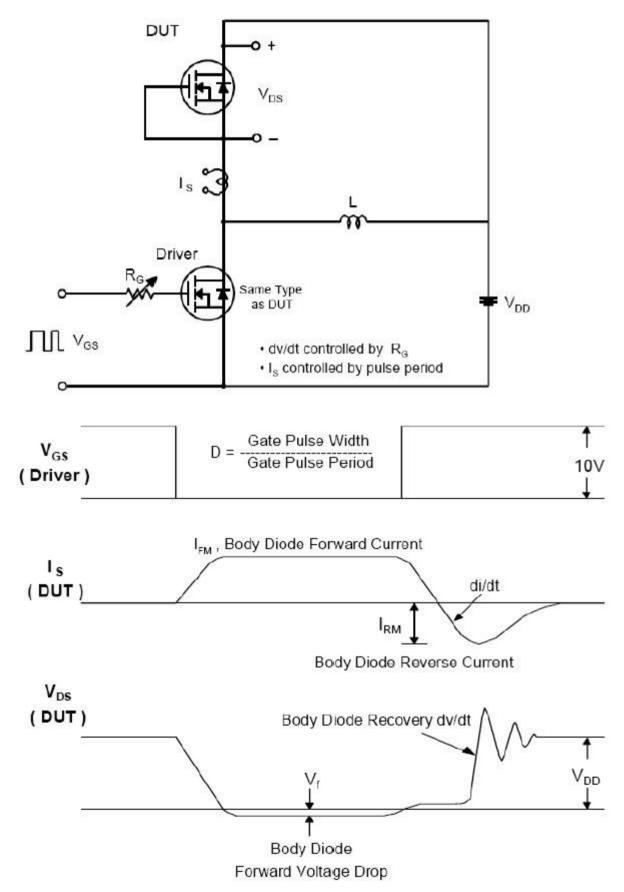


Fig 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms



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